

The CMS pixel readout chip for the Phase 1 Upgrade

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on behalf of the CMS Collaboration

Pixel 2014 Workshop

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Outline

- Upgrade Phase I CMS pixel detector
- Upgrade Phase I CMS pixel readout chip
- High rate ROC performance
- ROC radiation hardness
- Layer 1 readout chip status
- Conclusion

Details of ROC modifications see in the talk of Hans-Christian Kästli (PSI)

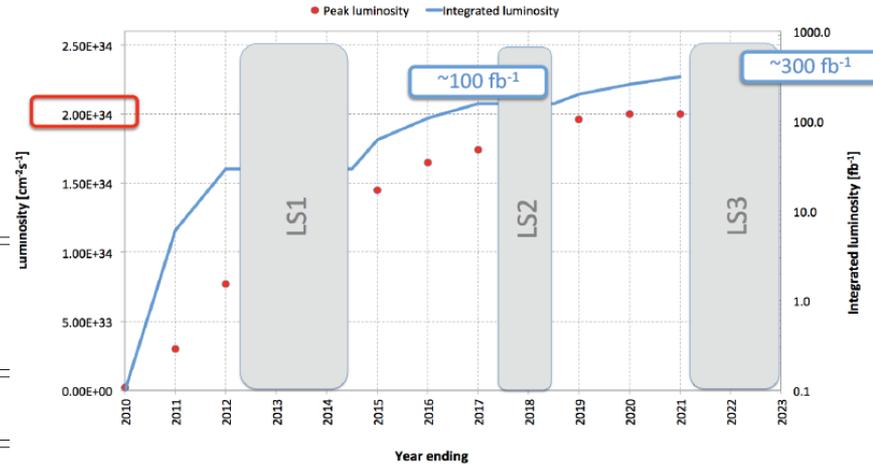
*"Frontend Electronics development for the CMS pixel detector upgrade!", **Pixel 2012, Inawashiro, JP***

Upgrade Phase I CMS Pixel Detector

Upgrade motivation

New Read-Out Chip needed that could efficiently function at $L > 1 \times 10^{34} \text{ cm}^{-2} \text{ sec}^{-1}$

Detector	Radius (cm)	% Data loss for ($\text{cm}^{-2}\text{s}^{-1}$ @ ns)		
		1×10^{34} @ 25	2×10^{34} @ 25	2×10^{34} @ 50
Current detector				
BPIX1	4.4	4.0	16.0	50.0
BPIX2	7.3	1.5	5.8	18.2
BPIX3	10.2	0.7	3.0	9.3
FPIX1 and 2		0.7	3.0	9.3
Upgrade detector				
BPIX1	3.0	1.19	2.38	4.76
BPIX2	6.8	0.23	0.46	0.93
BPIX3	10.2	0.09	0.18	0.36
BPIX4	16.0	0.04	0.08	0.17



Already at the end of 2015 luminosity of $L=1.5 \times 10^{34} \text{ cm}^{-2}\text{sec}^{-1}$ expected

The detector need to be operational till LS3 (2022) at $L=2 \times 10^{34} \text{ cm}^{-2}\text{sec}^{-1}$

Upgrade pixel detector

- **Upgrade Pixel detector:** 4 barrel layers (instead of 3) and 3 forward disks on each side (instead of 2)
- **Installation:** during extended winter shutdown in 2016/17

Bpix: 1184 modules, 48M->79M pixels

L1 r= 30mm, 96 modules, 2×TBM09, 4 links

L2 r= 68mm, 224 modules, TBM09, 2 links

L3 r=109mm, 352 modules, TBM08, 1 link

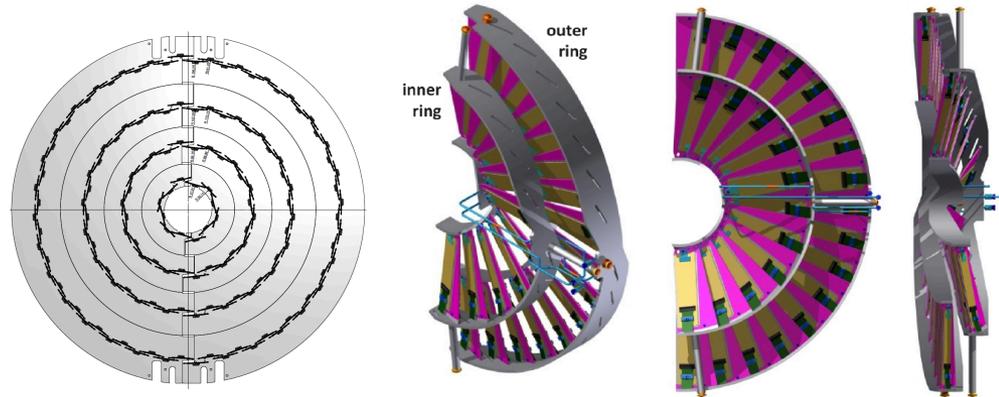
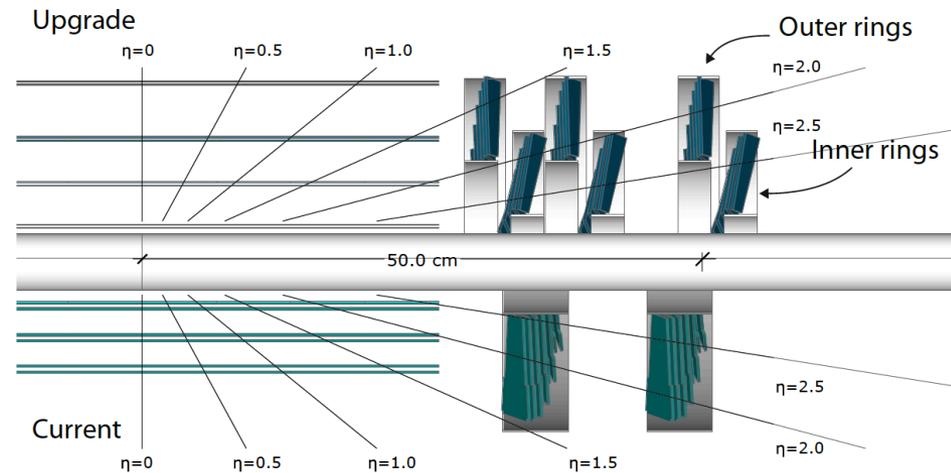
L4 r=160mm, 512 modules, TBM08, 1 link

Fpix: 672 modules, 18M->45M pixels

3 Disks r=45-161mm, 6×112 modules, TBM08, 1 link

Outer ring rotated by 20° (turbine like)

Inner ring rotated by 20° and tilted by 12° with respect to IP



Pixel module

Module parameters:

Full Size: 66.6 mm × 25/21.6 mm (L2-4/L1)

Sensor size: 66.6 mm × 18.8 mm

ROC size: 10.55 mm × 8.02mm

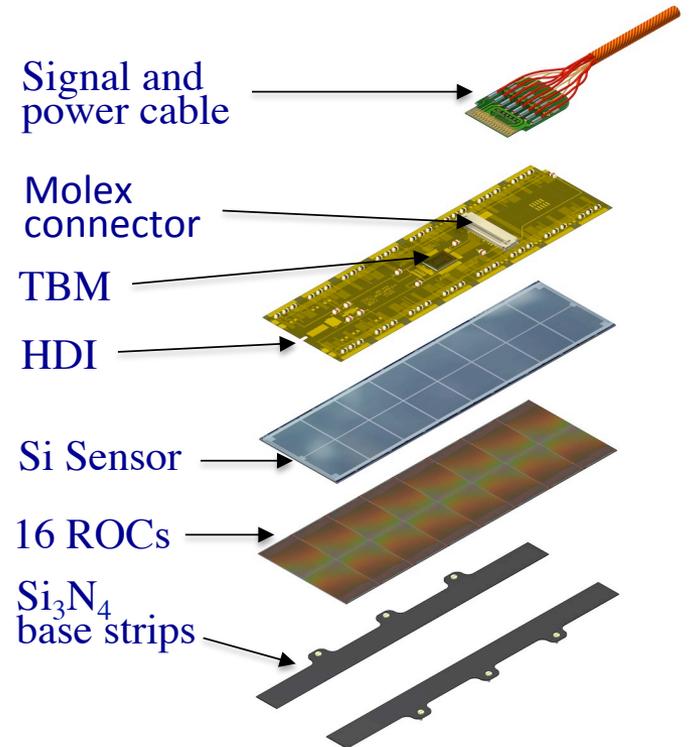
Weight: < 3 g

Si sensor thickness: 285 μm

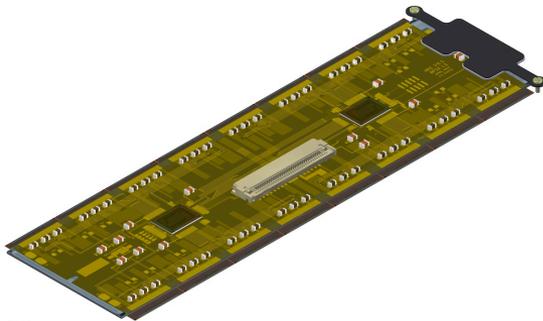
ROC thickness: 75/175 μm (L1/L2-4)

Segmentation: 16 x 52 x 80 = 66560 pixels

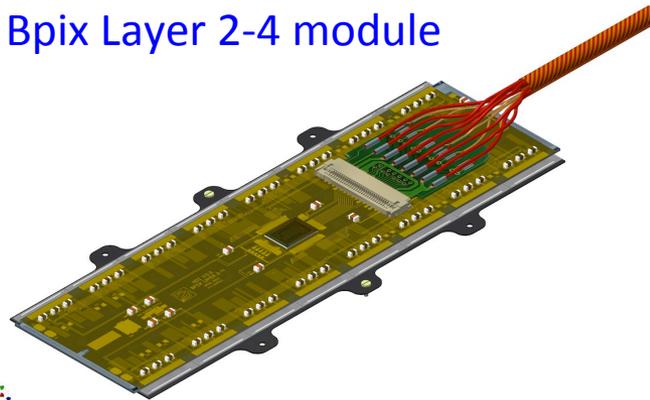
Power: 2.0 W



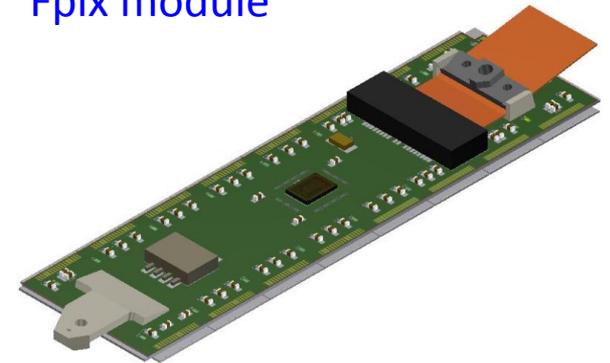
Bpix Layer 1 module



Bpix Layer 2-4 module



Fpix module



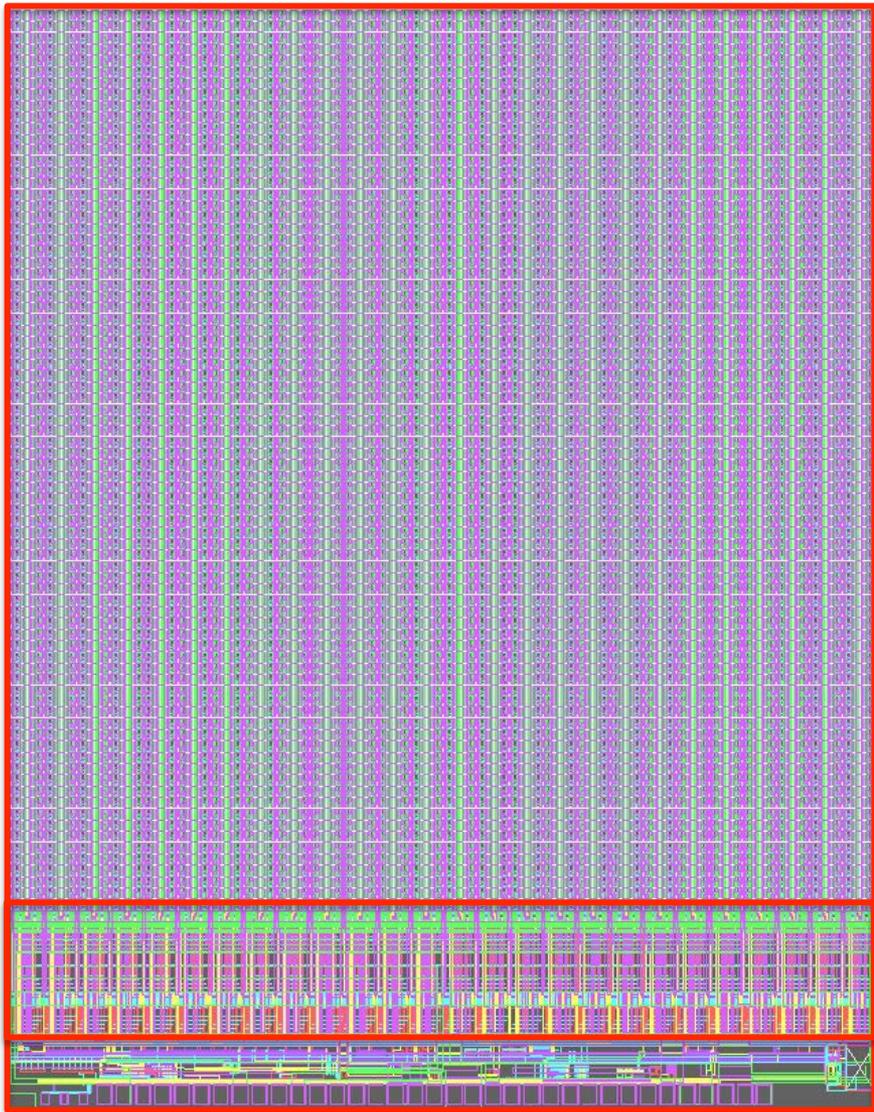
Upgrade Phase I Pixel Readout Chip

Upgrade Phase I ROC

- Based on present analog chip
- Limitations of present chip at Phase I
 1. Buffer sizes for level 1 trigger latency
 - Action: increase buffer sizes increased (next slide)
 2. Readout related dead time at higher data volumes
 - Action: additional readout buffer stage added
 3. Higher readout bandwidth needed for higher module number but the same number of fibers
 - Action: digital instead of analog readout with following modifications:
 - ✓ on chip ADC
 - ✓ new fast digital readout links
 - ✓ PLL to provide higher frequencies
 - ✓ modification to control logic
- Lower signal threshold required for extend longevity of detector

Layout of the Phase I ROC

(1)

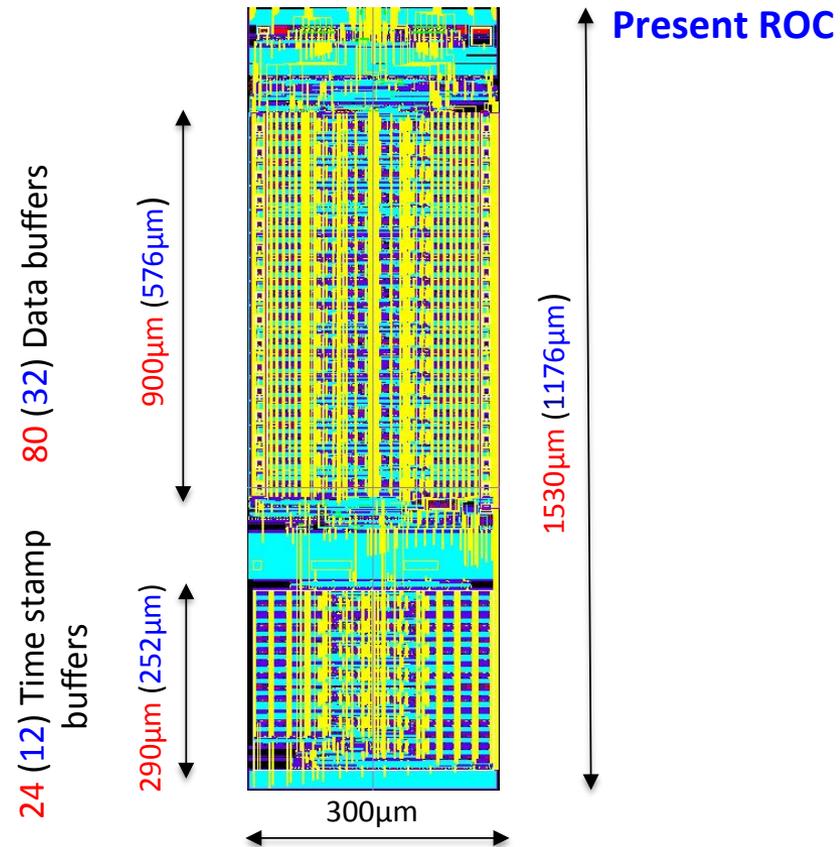


(2)

(3)

(1) **Pixel array:** 52 columns and 80 rows arranged in groups of 2 columns (26 double columns)

(2) **26 Double Column Interfaces**



(3) **Control Interface Block:** readout logic, DACs, I2C interface, voltage regulators, reference and pads

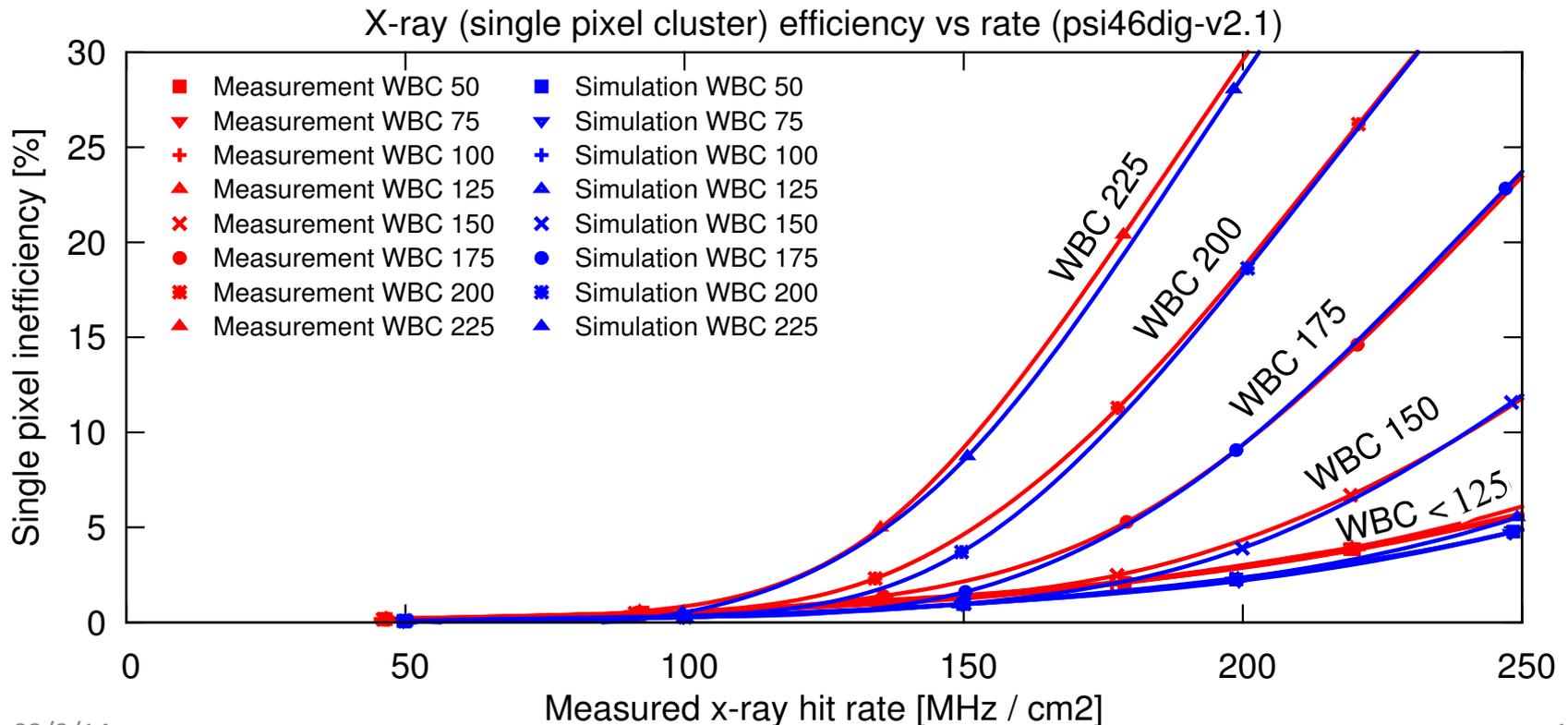
Analog vs digital ROC

	PSI46V2	PSI46DIG
ROC size	7.9 mm x 9.8 mm	7.9 mm x 10.2 mm
Pixel size	100 μm x 150 μm	100 μm x 150 μm
Smallest radius	4.3cm	2.9cm
Settable DACs / registers	26 / 2	19 / 2
Power Up condition	not defined	default values
pixel charge readout	analog	digitized, 8bit
Readout speed	40 MHz	160 Mbit/s
Time stamp Buffer size	12	24
Data Buffer size	32	80
Output Buffer FIFO	no	yes
Double column Speed	20 MHz	20 MHz (40 MHz)
Metal layers	5	6
Leakage current compensation	yes	no
in-time threshold	3500 e	< 2000 e
PLL	no	yes
Data loss at max Operating flux	$\sim 3.8\%$ at 120 MHz/cm ²	1.6% at 150 MHz/cm ² ($\sim 3\%$ at 580 MHz/cm ²)

High rate X-rays tests

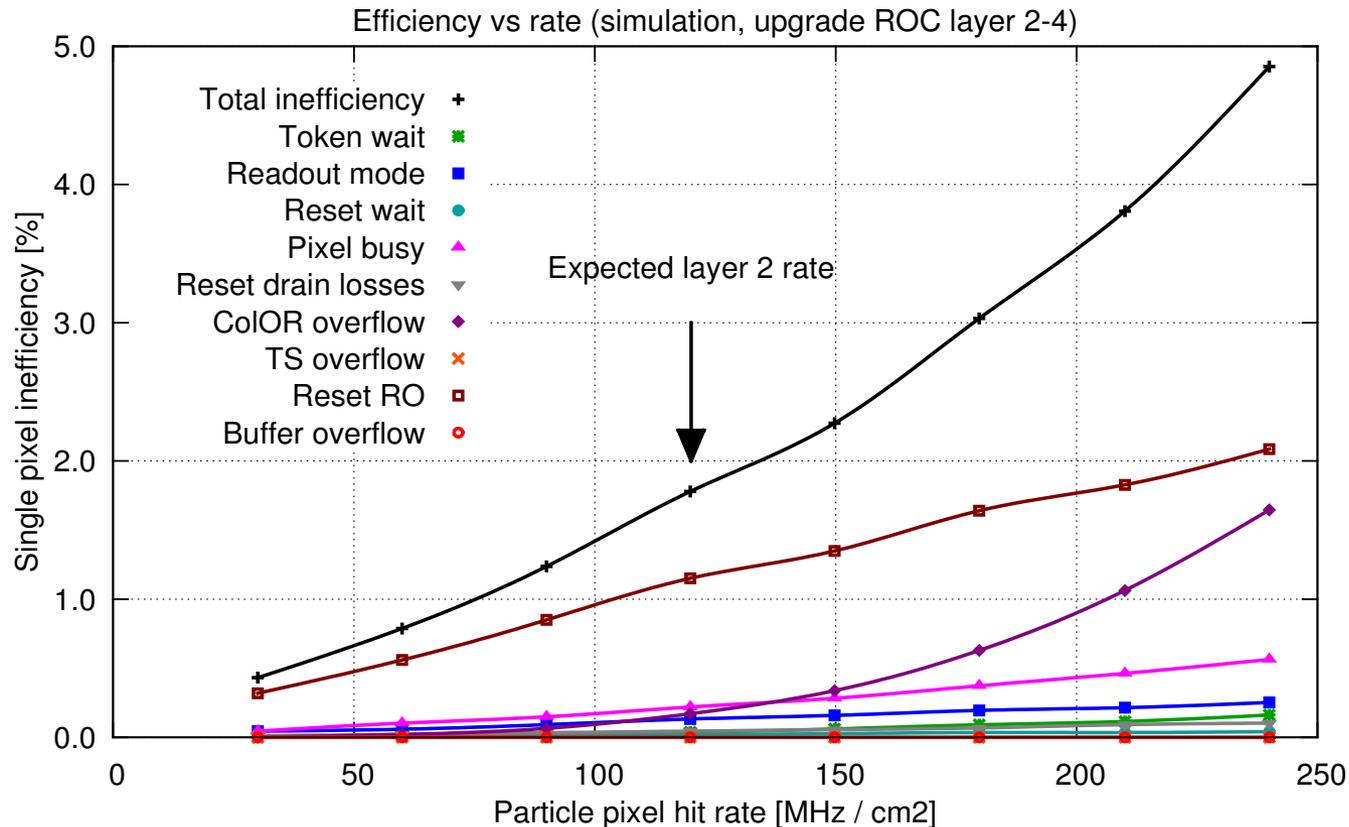
High rate X-rays: measurements vs simulation

- Definition: efficiency = (#readout calibrate signals) / (#injected calibrate signals)
- Periodic calibrate signal injection and trigger at rate of 30kHz
- X-ray inefficiency mostly due to limited time stamp buffer size
- Low WBC (CMS level 1 trigger latency) bypass this limitation
- Remaining inefficiency due to pixel busy and column drain



High rate particles: simulation

- Main difference with respect to X-ray
 - more hits per time stamp: 2.3 (particles) vs 1 (X-ray)
 - module readout simulated, not single ROC
 - random (non periodic) trigger used, hence more data loss mechanisms contribute
- WBC=156 (CMS level 1 trigger latency), random trigger at 100kHz rate
- Expected hit rate at R=6.8cm (Bpix Layer 2) – 120MHz/cm²

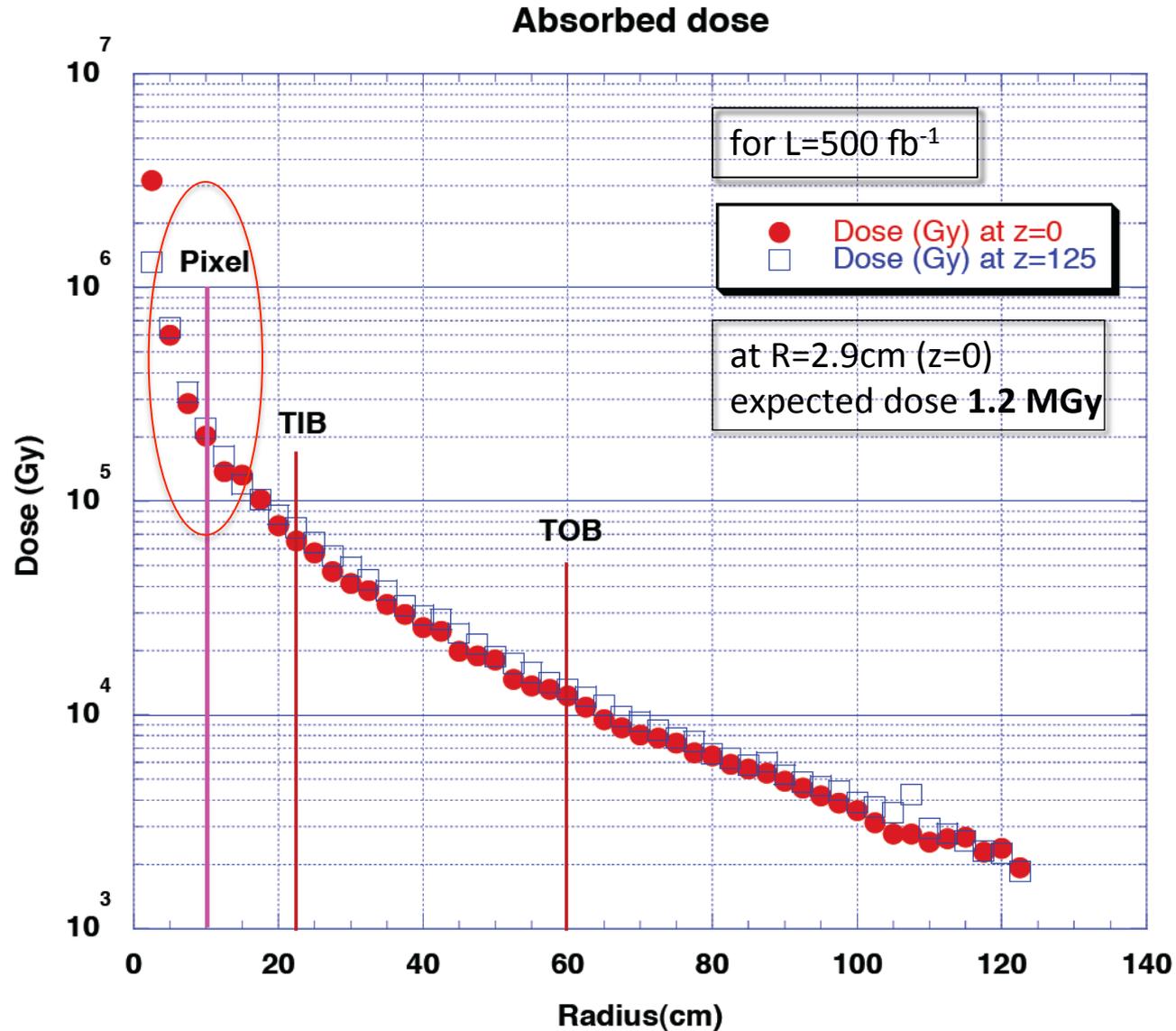


Irradiation studies

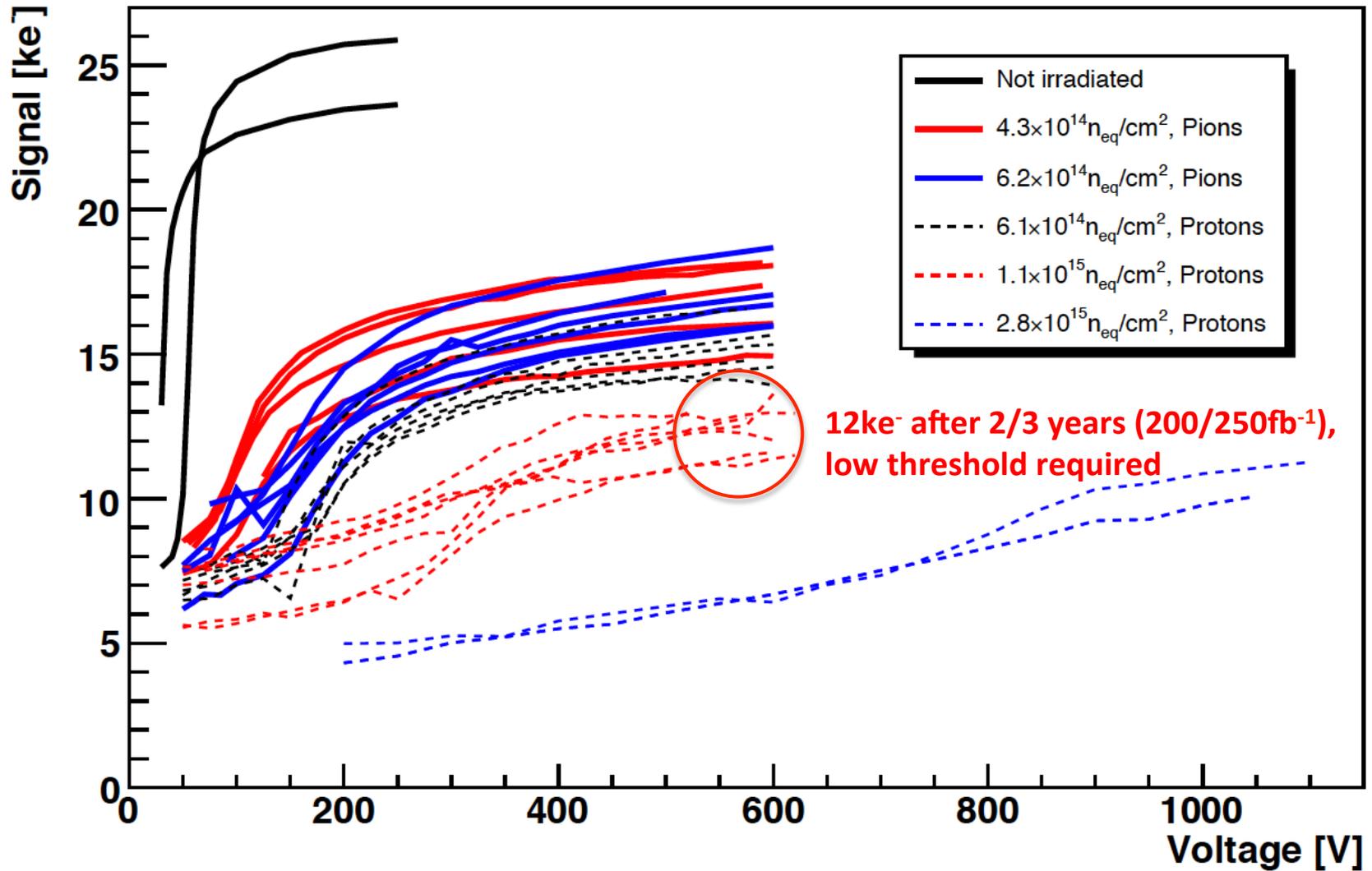
Acknowledgment:

The research leading to these results has received funding from the European Commission under the FP7 Research Infrastructures project AIDA, grant agreement no. 262025

Expected irradiation dose

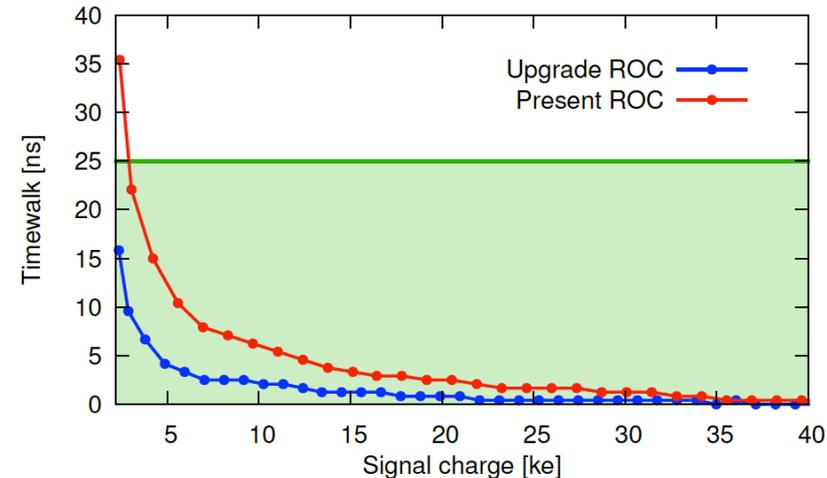
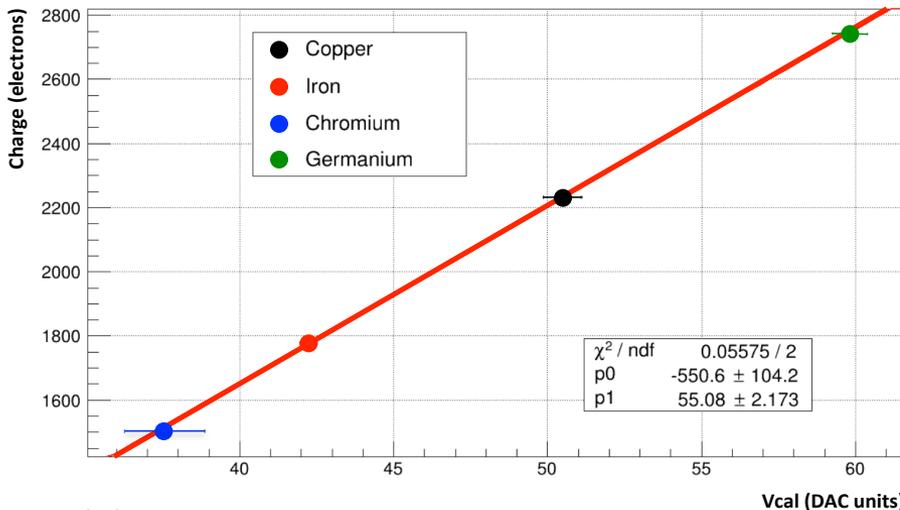
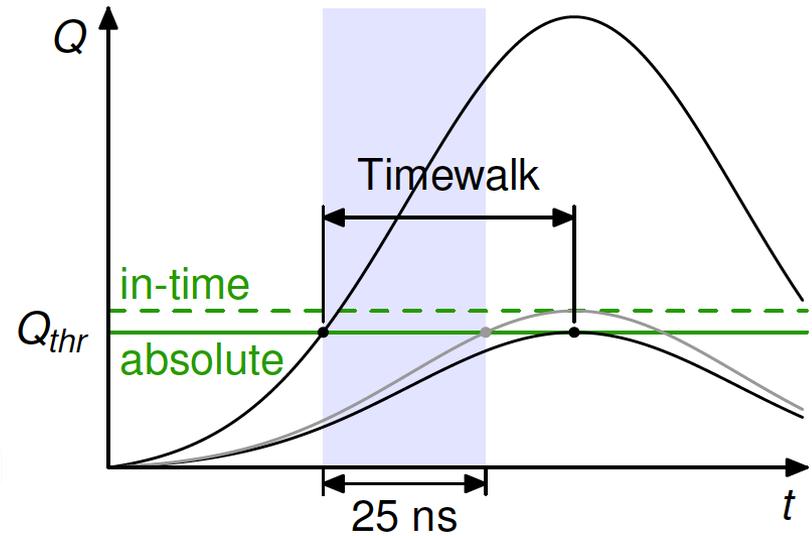


CCE in silicon



Timewalk and threshold

- **Timewalk(T_{TM})**: time difference between moments at which largest and lowest signals cross ROC threshold
 - analog ROC: $T_{TM} > 25\text{ns}$
 - digital ROC: $T_{TM} < 16\text{ns}$
- **Minimum threshold**:
 - analog ROC: $3200e^-$
 - digital ROC: $< 1800e^-$ (also due to reduced x-talk in new ROC layout)
- **Low threshold** increases detector longevity



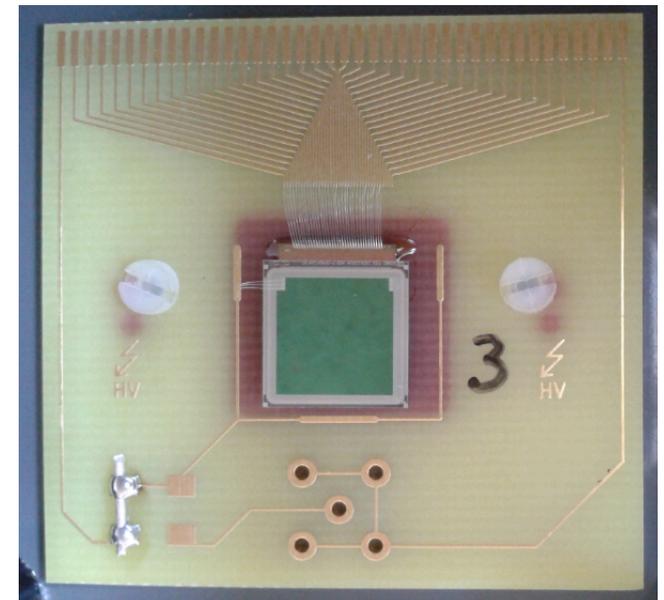
Irradiation at KIT: samples and dose

- Irradiation done
 - with proton beam, proton energy 23 MeV
 - at two doses: 60Mrad ($2 \times 10^{14} \text{p/cm}^2$) and 120Mrad ($4 \times 10^{14} \text{p/cm}^2$)
- 6 samples irradiated at each dose
 - 4 samples powered and 2 - not during irradiation

Irradiation setup

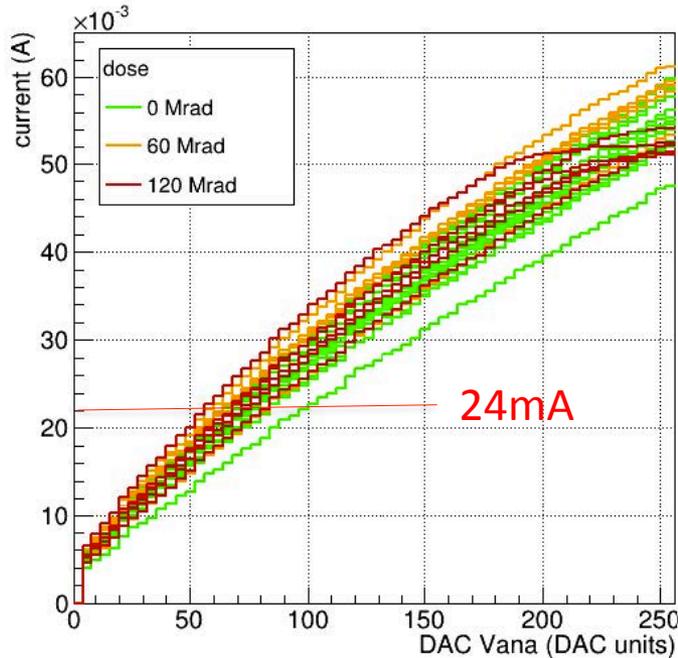


Irradiated sample

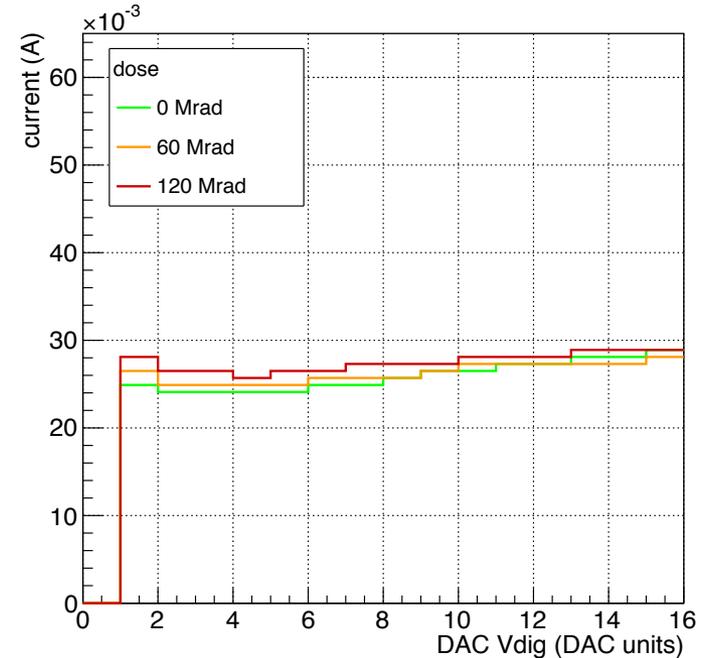


Analog and digital current

analog current of DAC Vana



digital current of DAC Vdig

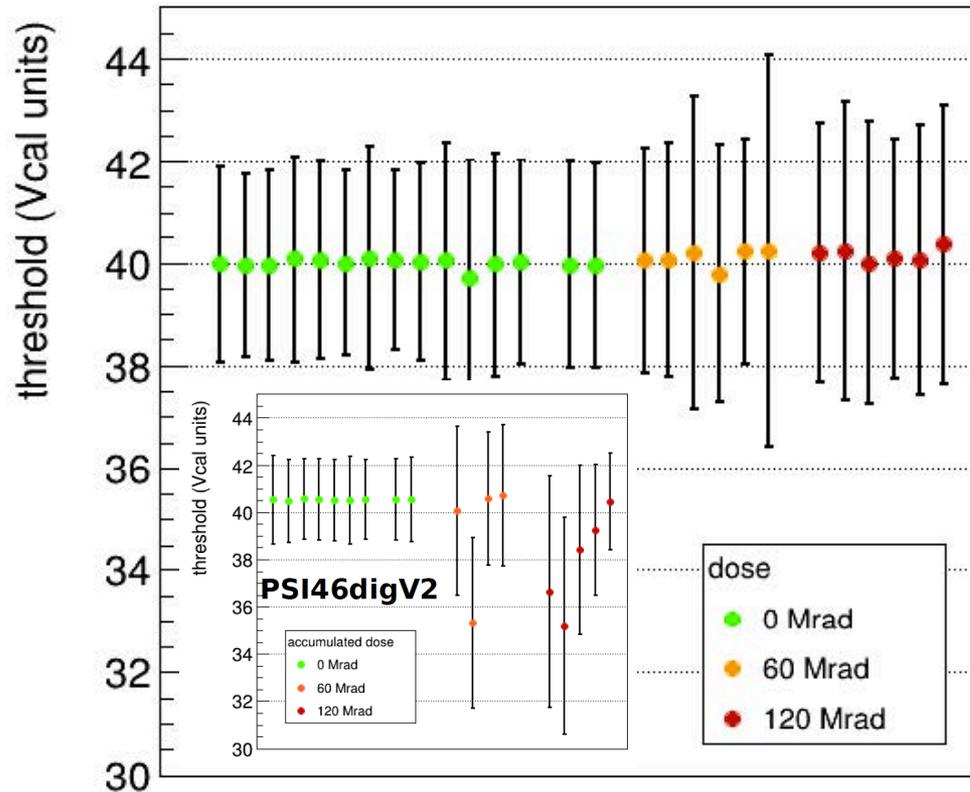


- Dynamic range of **Vana** DAC before and after irradiation is fine
- Minor increase of **Iana** after irradiation
- For several samples irradiated to 120MRad observed current saturation above **Vana**=170

- Small dependence of **I_{dig}** vs **V_{dig}** DAC, as expected
- Remains the same after irradiation

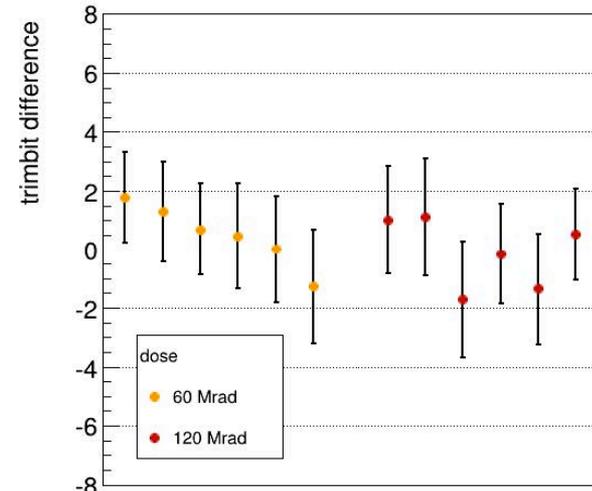
Trimming: Vcal threshold and trim bits

Trimming - threshold mean and width



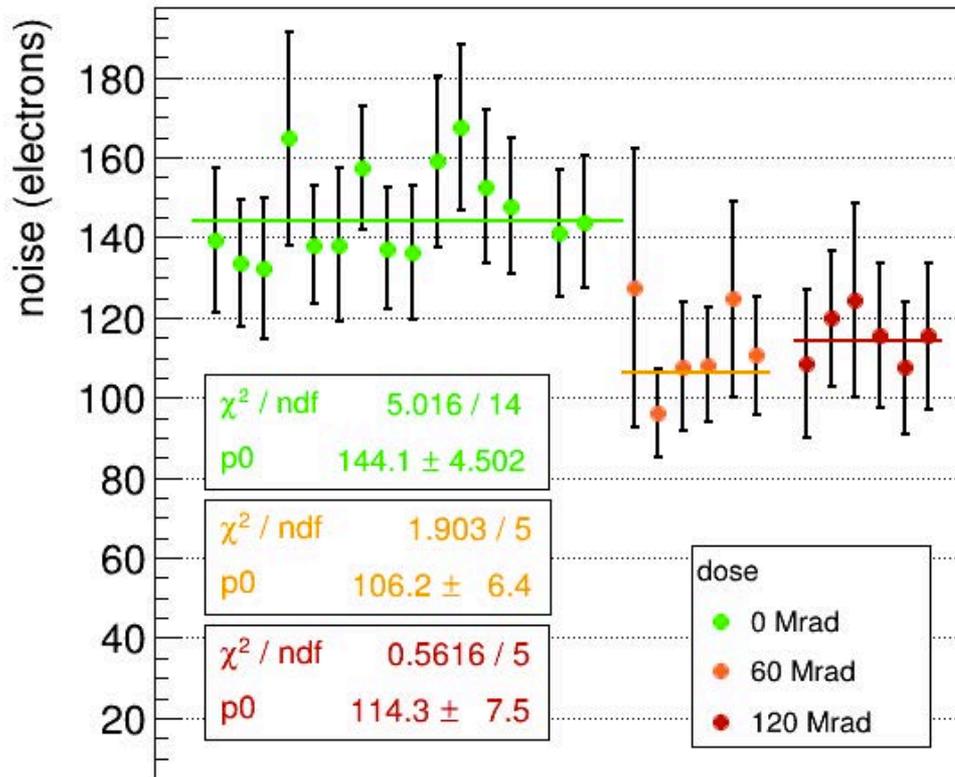
NB: **PSI46digV2** – previous version of the final chip, shown for comparison

- Before and after irradiation ROC trimmed to (internal calibrate signal) **Vcal=40**
- Trimming works well before and after irradiation
- Small increase (30%) of threshold spread within ROC observed
- After irradiation mean of trim bit distributions shifts slightly around 0 (both positive and negative)
- **Trimbit difference - mean and width**



Noise

SCurves - mean and width (based on 50e⁻/Vcal)



- Average noise
 - before irradiation – 144 ± 5e⁻
 - after 60 Mrad – 106 ± 6e⁻
 - after 120 Mrad – 114 ± 8e⁻
- Used conversion factor 50e⁻/Vcal
- Conversion factor after irradiation is not known
- Noise spread among pixels in ROC stays almost the same

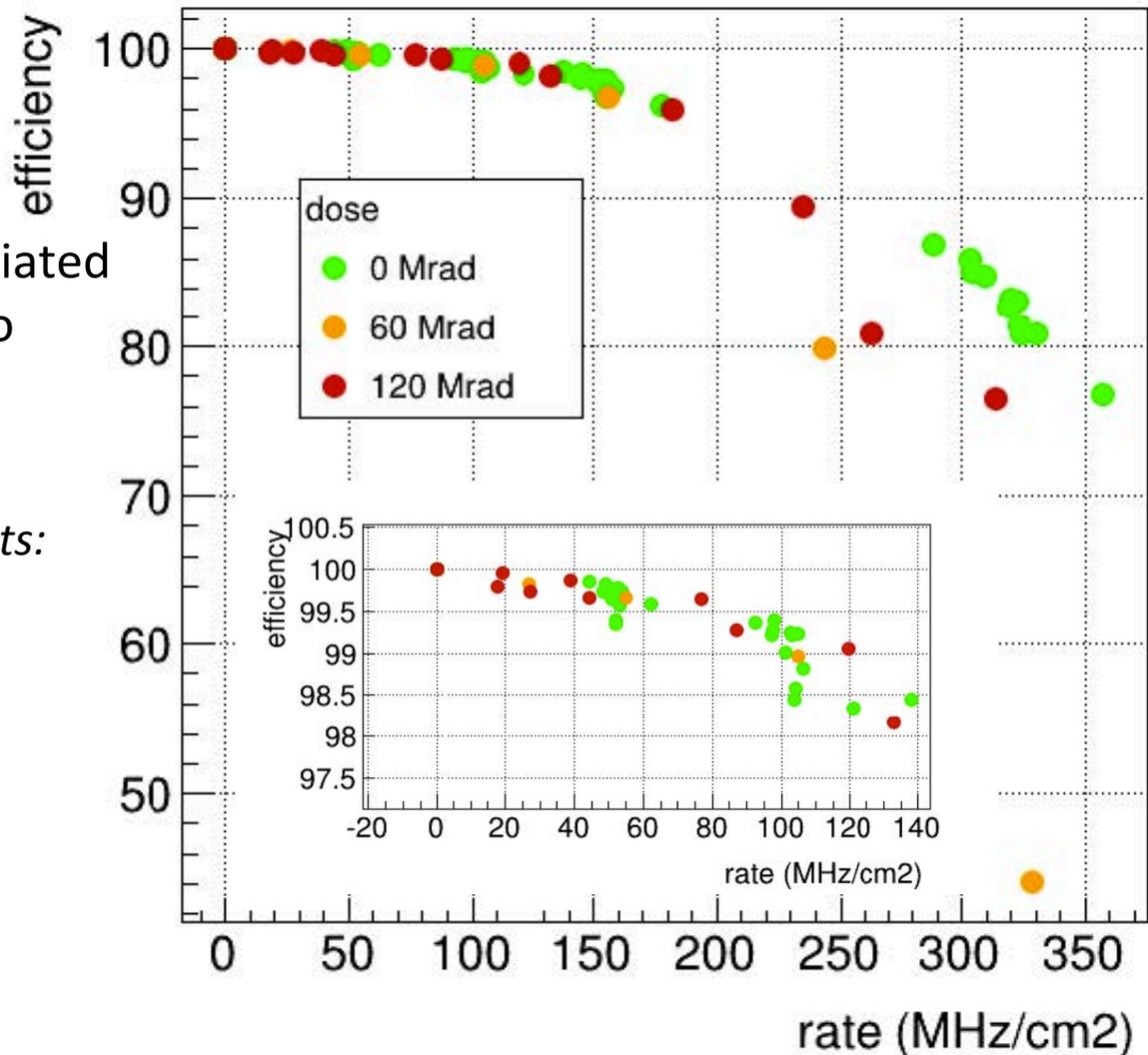
Pixel efficiency with high rate Xrays

Efficiency at 120MHz/cm²

- measured with Xrays
- higher than **98.5%** and
- stays the same for non irradiated and irradiated samples up to 120MRad

NB

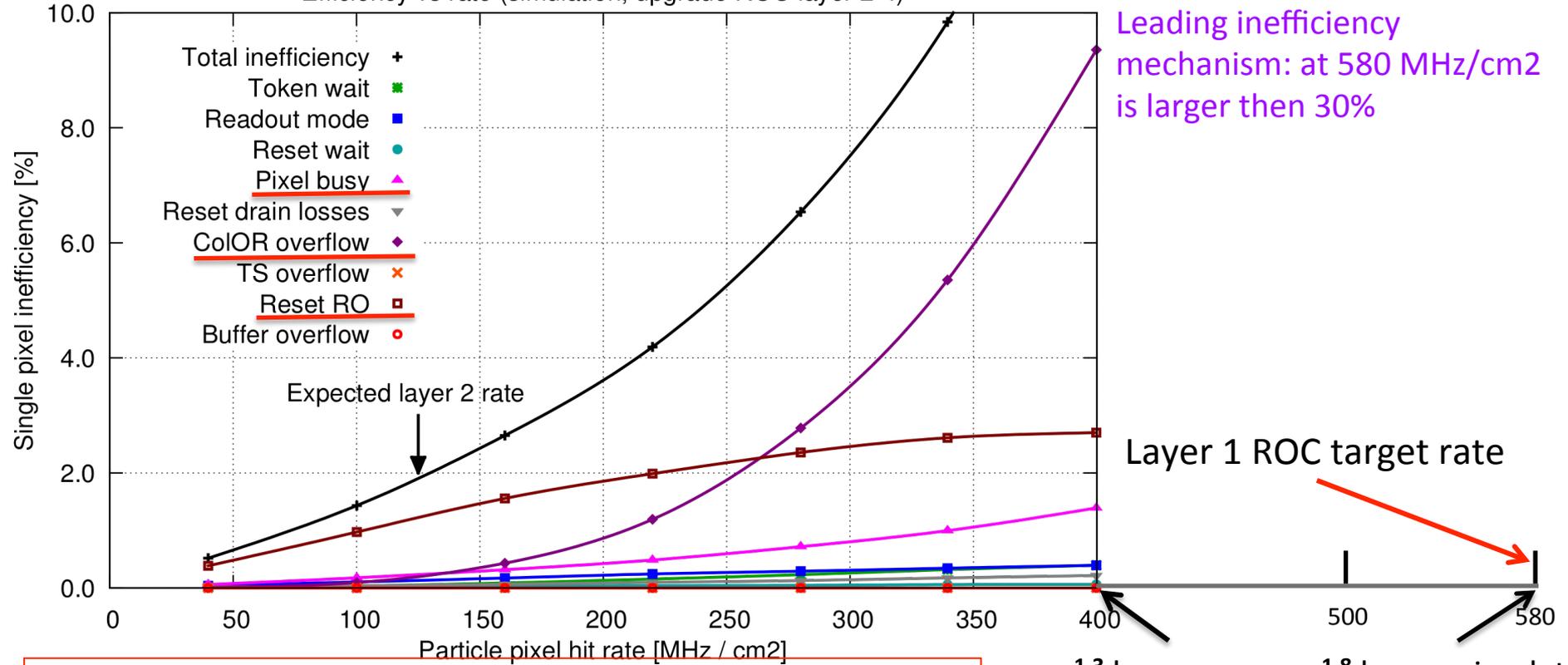
*Not the best possible measurements:
for Dose=0 VICoLoR DAC was not
optimized*



Layer I ROC

Bpix Layer 1 ROC

Efficiency vs rate (simulation, upgrade ROC layer 2-4)



Leading inefficiency mechanism: at 580 MHz/cm² is larger than 30%

Layer 1 ROC target rate

$r^{-1.3}$ low as measured at P5
 $r^{-1.8}$ low as simulated by PYTHIA

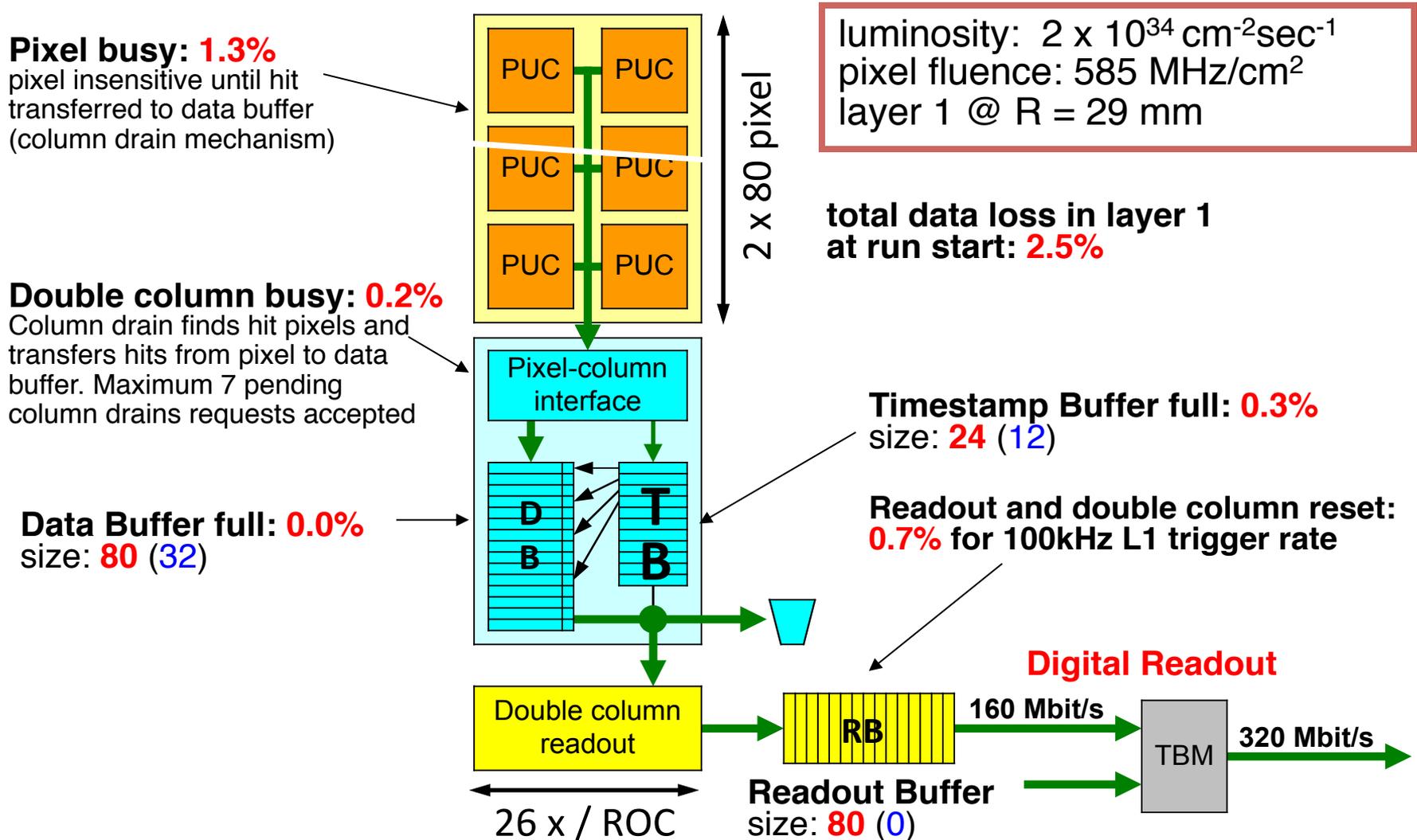
Main mechanisms of data losses addressed in the design:

1. pixel busy
2. ColOR overflow
3. readout reset

Bpix Layer 1 ROC status

- Double column logic needed modifications for higher data rates
- Hence Dynamic Cluster Column Drain architecture implemented
 - dynamic cluster (2×2 pixels) finding in double column
 - transfer speed increased from 20MHz to 40MHz
 - data throughput in double column improved by factor of 3.5
 - pixel dead time (pixel busy) reduced to 1.3%
 - column busy (leading) inefficiency completely gone
- Dead time free data buffer management (reset RO)
 - buffer logic improved mechanism to protect valid hits from overwriting
 - related data loss reduced by at least factor of 5

Data loss mechanisms in Upgrade ROC for layer 1



Bpix Layer 1 ROC status

- Chip size almost the same as for Layer 2-4 ROC (PSI46digV2.1)
- Pads and data format the same as for PSI46digV2.1
- Power consumption the same or lower than for PSI46digV2.1
- **Submission at the end of 2014**

Conclusion

- After three iterations (2012-2014) and thorough investigations in labs, beam tests and irradiation ROC for Bpix Layer 2-4 and Fpix works as expected
- Signal threshold could be set as low as $1800e^-$ (compare with present ROC of $3200e^-$)
- Hit efficiency (measured with X-rays and simulated for X-rays and particles) is higher than 98% at expected hit rate ($120\text{MHz}/\text{cm}^2$) for Bpix Layer 2 even after irradiation of 120MRad
- Production submission is done in July 2014 (48 wafers, the rest will be produced at the end of 2014)
- Design of Bpix Layer 1 ROC is almost done and submission for production is planned at the end 2014

Acknowledgment

In this presentation work of many people from the CMS Pixel Upgrade Phase I community is used. I would like to thank all of them. Special thank to

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Tilman Rohe (PSI)

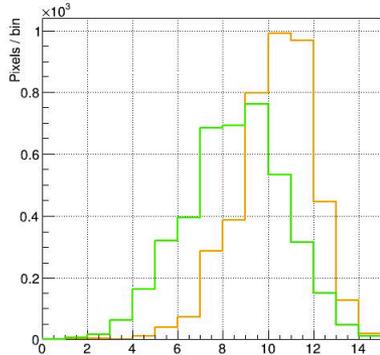
Silvan Streuli (PSI)

Jackson Young (Uni of Kansas)

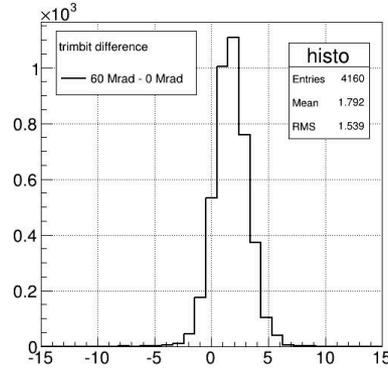
Backup slides

Trimming: trim bits

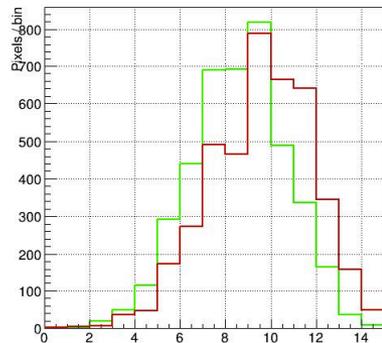
TrimMap_C0 Distribution



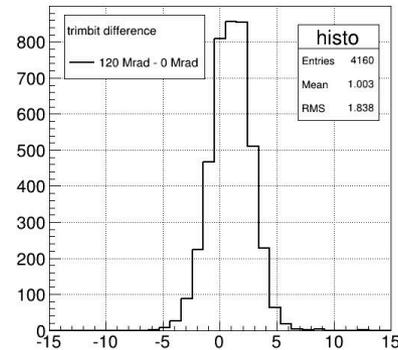
Trimbit difference



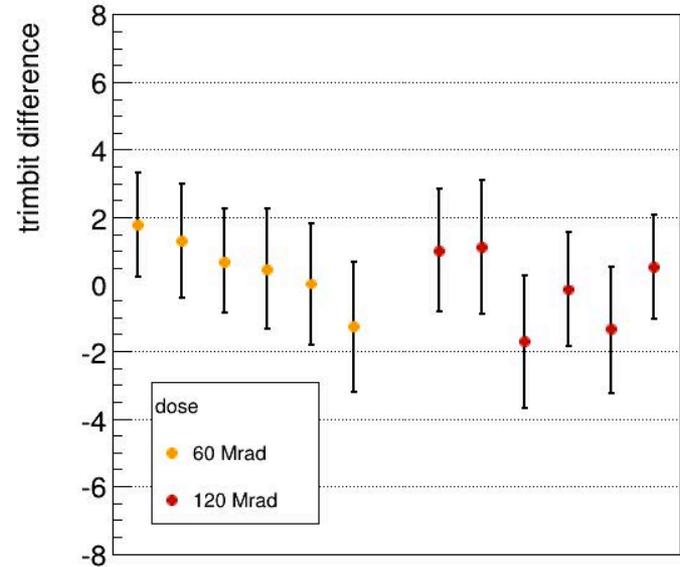
TrimMap_C0 Distribution



Trimbit difference



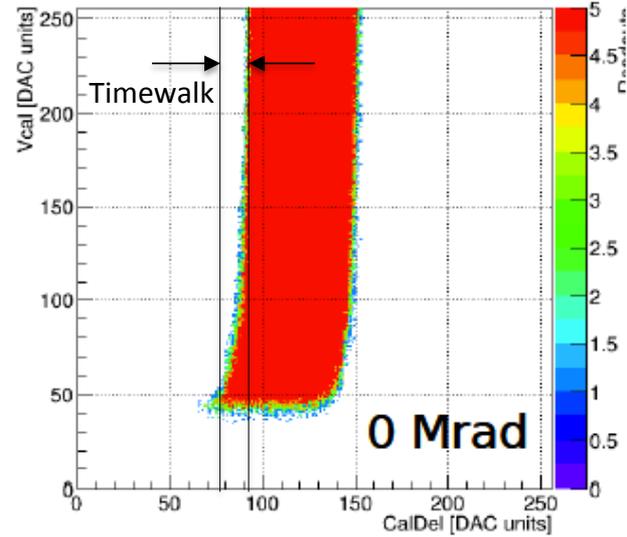
Trimbit difference - mean and width



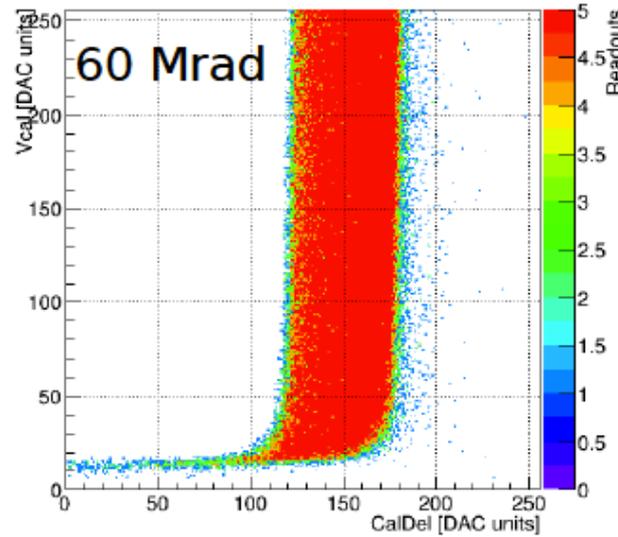
- After irradiation mean of trim bit distributions shifts around 0 (both positive and negative)
- This may mean increase of trim bits non linearity (to be checked)
- Degradation of pixel threshold uniformity after irradiation to be checked

Reproducibility: mean=0.1; RMS=0.6

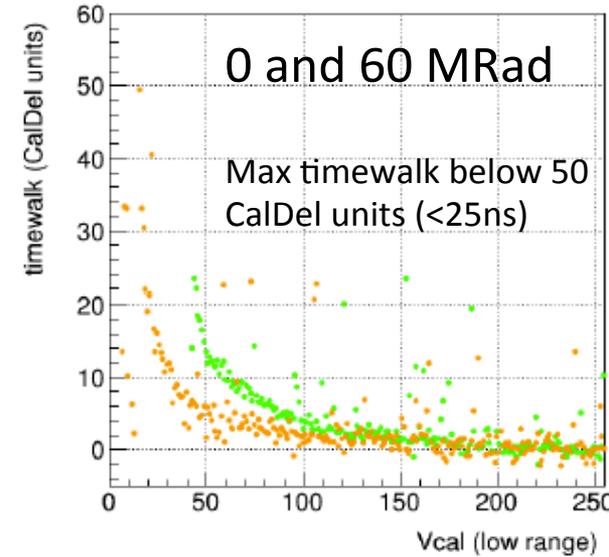
Timewalk



VcalCalDel_c5r5_C0



VcalCalDel_c5r5_C0



timewalk

